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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/803,805	03/18/2004	Aelan Mosden	FKL-005	5615	
	37694 7590 08/21/2008 WOOD, HERRON & EVANS, LLP (TOKYO ELECTRON)			EXAMINER	
2700 CAREW TOWER			BAND, MICHAEL A		
441 VINE STREET CINCINNATI, OH 45202			ART UNIT	PAPER NUMBER	
			1795		
			NOTIFICATION DATE	DELIVERY MODE	
			08/21/2008	ELECTRONIC	

# Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Notice of the Office communication was sent electronically on above-indicated "Notification Date" to the following e-mail address(es):

dgoodman@whepatent.com usptodock@whepatent.com

	Application No.	Applicant(s)
	10/803,805	MOSDEN, AELAN
Office Action Summary	Examiner	Art Unit
	MICHAEL BAND	1795
The MAILING DATE of this communication appeariod for Reply	ppears on the cover sheet with the o	correspondence address
A SHORTENED STATUTORY PERIOD FOR REP WHICHEVER IS LONGER, FROM THE MAILING I - Extensions of time may be available under the provisions of 37 CFR 1 after SIX (6) MONTHS from the mailing date of this communication.  - If NO period for reply is specified above, the maximum statutory perior. Failure to reply within the set or extended period for reply will, by statu Any reply received by the Office later than three months after the mail earned patent term adjustment. See 37 CFR 1.704(b).	DATE OF THIS COMMUNICATION  1.136(a). In no event, however, may a reply be tire  d will apply and will expire SIX (6) MONTHS from the, cause the application to become ABANDONE	N. nely filed the mailing date of this communication. ED (35 U.S.C. § 133).
Status		
1) ☐ Responsive to communication(s) filed on 28. 2a) ☐ This action is <b>FINAL</b> . 2b) ☐ Th  3) ☐ Since this application is in condition for allow closed in accordance with the practice under	is action is non-final. ance except for formal matters, pro	
Disposition of Claims		
4)  Claim(s) 34-51 is/are pending in the applicating 4a) Of the above claim(s) is/are withdrest 5)  Claim(s) is/are allowed.  5)  Claim(s) 34-51 is/are rejected.  7)  Claim(s) 40 is/are objected to.  8)  Claim(s) are subject to restriction and/or subject to subject to by the Examing 10)  The drawing(s) filed on is/are: a) and according to a subject to subject to by the Examing 10. The drawing(s) filed on is/are: a) according to a subject to subject to by the Examing 10. The drawing(s) filed on is/are: a) according to a subject to subject	rawn from consideration.  /or election requirement.  ner.  ccepted or b) □ objected to by the	
Applicant may not request that any objection to the Replacement drawing sheet(s) including the corre	ection is required if the drawing(s) is ob	jected to. See 37 CFR 1.121(d).
Priority under 35 U.S.C. § 119		
12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of:  1. Certified copies of the priority document 2. Certified copies of the priority document 3. Copies of the certified copies of the priority document application from the International Bure.  * See the attached detailed Office action for a list	nts have been received. nts have been received in Applicat iority documents have been receive au (PCT Rule 17.2(a)).	ion No ed in this National Stage
Attachment(s)  1) Notice of References Cited (PTO-892)  2) Notice of Draftsperson's Patent Drawing Review (PTO-948)  3) Information Disclosure Statement(s) (PTO/SB/08)  Paper No(s)/Mail Date	4)  Interview Summary Paper No(s)/Mail D 5)  Notice of Informal F 6)  Other:	ate

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#### **DETAILED ACTION**

#### Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 7/28/2008 has been entered.

## Claim Objections

2. Claim 40 is objected to because of the following informalities: contains the limitation of a processing module being a deposition module but in line 3 discloses the processing module being an etching module. Appropriate correction is required.

### Claim Rejections - 35 USC § 112

- 3. The following is a quotation of the second paragraph of 35 U.S.C. 112:
  The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.
- 4. Claims 44 and 51 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

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5. Regarding claim 44, the phrase "more particularly" renders the claim indefinite because it is unclear whether the limitations following the phrase are part of the claimed invention. See MPEP § 2173.05(d).

6. Claim 51 recites the limitation "the controller". There is insufficient antecedent basis for this limitation in the claim.

#### Claim Rejections - 35 USC § 102

7. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 8. Claims 34, 39- are rejected under 35 U.S.C. 102(b) as anticipated by or, in the alternative, under 35 U.S.C. 103(a) as obvious over Tepman (US Patent No. 5,223,112).

With respect to claims 34, 46, and 50, Tepman discloses a removable shutter apparatus for a deposition or etching apparatus including a shuttering mechanism disposed within a semiconductor processing chamber (abstract), with the chamber being evacuable (col. 2, lines 49-52). Tepman further discloses removing and replacing a used shutter plate with a new shutter plate without shutting down the system (abstract), where the shutter plate (i.e. maintenance item) [66] is mounted into a plating position (i.e. mounting structure) that is removable (col. 3, lines 59-68). Tepman further discloses a robotic shuttling mechanism (i.e. transfer system) [53] comprising a shutter

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blade (i.e. wafer transfer mechanism) [51] to transfer both product substrates (i.e. wafers) and shutter plates into and out of the chamber [42], with the old shutter plate being a first maintenance item and the new shutter plate being a second maintenance item (abstract; fig. 2; col. 37-42; col. 4, lines 15-25), with fig. 2 depicting a wafer [46'] placed on a wafer holder. Tepman also discusses that due to the time required to remove the wafer [46''] and replace it with shutter plate [66'], the pressure of the chamber is held constant (col. 4, lines 4-10), thus the processing module is not exposed to an outside environment. Despite Tepman not disclosing a controller being used, it is either inherent or obvious that since a robotic shuttling mechanism is being used to transfer wafers and shutter plates, a controller is present and programmed to control the robot.

With respect to claims 39-45 and 47-49, Tepman further discloses a removable shutter apparatus for a deposition or etching apparatus including a shuttering mechanism disposed within a semiconductor processing chamber (abstract), with fig. 2 depicting the wafer [46"] facing upward. Fig. 3 depicts the shutter plate [66] being annular, where during the replacement of the wafer, the shutter plate is moved to block the path of the plating ions, causing a build-up of material (or in the case of etching, the shutter plate would lose material) (col. 1, lines 49-57). The shutter plate [66] is lifted into plating position by a lift assembly [56] comprising four wafer-engaging fingers (i.e. pins) [57] (col. 2, lines 67-68; col. 3, lines 1-3 and 59-66). Fig. 3 also depicts two distinct arms, a shutter blade [51] for the wafers and a transfer arm [68] for moving the shutter plate [66].

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# Claim Rejections - 35 USC § 103

9. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

- (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 10. Claims 35-38 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tepman (US Patent No. 5,223,112) as applied to claim 34 above, and further in view of Takahashi et al (US Patent No. 5,364,219).

With respect to claim 35, the reference is cited as discussed for claim 34.

However Tep man is limited in that while it is disclosed to transfer the old shutter plate to a cleaning chamber or discharge bin (col. 4, lines 15-22), it is not specified how said old shutter plate is transferred to said cleaning chamber.

Takahashi et al teaches an apparatus for clean transfer associated with semiconductors (col. 1, lines 6-14) where fig. 4 depicts a maintenance chamber [14] having a processing chamber [18], another processing station [18], a clean stocker (i.e. storage assembly) [20], and (col. 3, lines 49-61). It is interpreted in fig. 4 for the top processing station [18] to be the film formation station and the bottom processing station [18] to be a maintenance station. Fig. 4 also depicts a clean box (i.e. exchange system) [28] for transporting a substrate (i.e. maintenance item) [38] between stations [18] and clean stocker [20], with figs. 5-8 depicting said clean box [28] transferring the substrate [38] between said clean box [28] and said processing (or maintenance) station [18]

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without breaking the vacuum (col. 5, lines 24-60). Takahashi et al cites the advantage of this exchange system as maintaining an operating environment stably clean (col. 2, lines 27-31).

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It would have been obvious to one of ordinary skill in the art to use the exchange system for transferring substrates (i.e. maintenance items) to transfer the old shutter plates (i.e. maintenance) items between processing and clean chambers to gain the advantage of maintaining a stably clean environment.

With respect claims 36-38, Takahashi et al further teaches in figs. 5-8 shutters (i.e. [40], [74] and transfer ports [22], [72] acting as gate valves to for an isolation assembly. Figs. 5-8 also depict a drive mechanism [60] comprising a robot arm [56] having a first transfer arm [62] and a first finger [68] that transfer the substrate (i.e. wafer or maintenance item) between the processing station [18], maintenance station [18], and clean stocker (i.e. storage) [20]. Despite Takahashi et al not disclosing a controller being used, it is either inherent or obvious that since a robotic arm is being used to transfer substrates, a controller is present and programmed to control the robot.

11. Claim 51 is rejected under 35 U.S.C. 103(a) as being unpatentable over Tepman (US Patent No. 5,223,112) as applied to claim 46 above, and further in view of

With respect to claim 51, the reference is cited as discussed for claim 46.

However Tepman is limited in that while it is inherent for the robotic wafer transfer mechanism to be controlled via a controller, it is not specified whether the controller

Yamauchi et al (US Patent No. 6,754,554).

monitors a processing recipe to determine when to exchange the old shutter plate (i.e. first maintenance item) for the new shutter plate (i.e. second maintenance item).

Yamauchi et al teaches a semiconductor manufacturing apparatus which has a processing chamber with a conveyance (i.e. transfer) system comprising a transfer arm for taking a semiconductor (i.e. wafer) in and out of the process chamber, where said apparatus has a control system via controller which controls the processing system and said conveyance system (abstract; col. 4, lines 65-67; col. 5, lines 1-8). Yamauchi et al further teaches that the controller follows programs (i.e. recipe), parameter data, control information, etc. for operating the processing chambers and conveyance mechanism in order to reduce system down time (i.e. improve system efficiency) (col. 1, lines 44-58).

It would have been obvious to one of ordinary skill in the art to use a controller that monitors a program (i.e. recipe) to operate the processing system and conveyance system taught in Yamauchi et al for transferring wafers and shutter plates of Tepman to gain the advantage of improving system efficiency.

### Response to Arguments

12. Applicant's arguments with respect to claim 34-51 have been considered but are most in view of the new ground(s) of rejection due to new claims and limitations.

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#### Conclusion

13. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Michael Band whose telephone number is (571) 272-9815. The examiner can normally be reached on Mon-Fri, 8am-4pm, EST.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Alexa Neckel can be reached on (571) 272-1446. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

14. Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

/M. B./

Examiner, Art Unit 1795